

TO-92 Pin Definition: 1. Gate 2. Drain 3. Source

V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)
600	11 @ V _{GS} =10V	0.3

General Description

The TSM1N60S is used an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain- to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

Features

- Robust high voltage termination
- Avalanche energy specified
- Diode is characterized for use in bridge circuits
- Source to Drain diode recovery time comparable to a discrete fast recovery diode.
- I_{DSS} and V_{DS(on)} specified at elevated temperature

Ordering Information

G
N-Channel MOSFET
IN-CHANNEL MOSPET

Block Diagram

Part No.	Package	Packing
TSM1N60SCT B0	TO-92	1Kpcs / Bulk
TSM1N60SCT A3	TO-92	2Kpcs / Ammo

Absolute Maximum Rating (Ta = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	600	V	
Gate-Source Voltage	V _{GS}	±30	V	
Continuous Drain Current	I _D	0.3	А	
Pulsed Drain Current	I _{DM}	1.2	А	
Continuous Source Current (Diode Conduction) ^{a,b}	Is	1	А	
Single Pulse Drain to Source Avalanche Energy (V_{DD} = 100V, V_{GS} =10V, I_{AS} =2A, L=10mH, R_G =25 Ω)	EAS	50	mJ	
Total Power Dissipation $@T_C = 25^{\circ}C$	P _{DTOT}	3	W	
Operating Junction Temperature	TJ	+150	°C	
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C	
Lead Temperature (1/8" from case)	TL	10	S	



Thermal Performance

Parameter	Symbol	Limit	Unit
Thermal Resistance - Junction to Ambient	RƏ _{JA}	125	°C/W
Thermal Resistance - Junction to Case	Rθ _{JC}	50	°C/W
Thermal Resistance - Junction to Lead	RƏ _{JL}	40	°C/W

Notes: Surface mounted on FR4 board t \leq 10sec

Electrical Specifications (Ta=25°C, unless otherwise noted)

Parameter	Conditions	Symbol	Min	Тур	Max	Unit
Static		·				
Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250uA	BV _{DSS}	600			V
Drain-Source On-State Resistance	V _{GS} = 10V, I _D = 0.3A	R _{DS(ON)}		11	13	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \text{uA}$	V _{GS(TH)}	2.0		4.0	V
Zero Gate Voltage Drain Current	V _{DS} = 600V, V _{GS} = 0V	I _{DSS}			10	uA
Gate Body Leakage	V_{GS} = ±20V, V_{DS} = 0V	I _{GSS}			± 100	nA
Forward Transconductance	V _{DS} ≧50V, I _D = 0.3A	g _{fs}		5		S
Diode Forward Voltage	I _S = 1A, V _{GS} = 0V	V _{SD}	-		1.5	V
Dynamic ^b						
Total Gate Charge		Qg		4.5	6	
Gate-Source Charge	V _{DS} = 400V, I _D = 1A, V _{GS} = 10V	Q _{gs}		1.1		nC
Gate-Drain Charge		Q_gd		2		
Input Capacitance		C _{iss}		155	200	
Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$	C _{oss}		20	26	pF
Reverse Transfer Capacitance	f = 1.0MHz	C _{rss}		3	4	
Switching ^c						
Turn-On Delay Time		t _{d(on)}		10	30	
Turn-On Rise Time	V _{GS} = 10V, I _D = 1A,	t _r		20	50	
Turn-Off Delay Time	V_{DS} = 300V, R_G = 6 Ω	t _{d(off)}		25	45	nS
Turn-Off Fall Time		t _f		24	60]

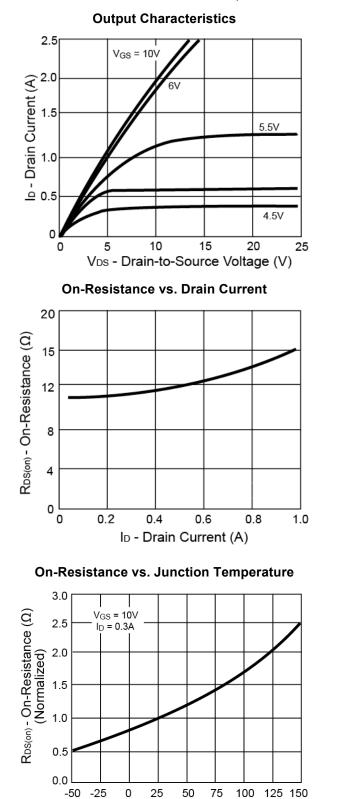
Notes:

a. Pulse test: pulse width <=300uS, duty cycle <=2%

b. For design reference only, not subject to production testing.

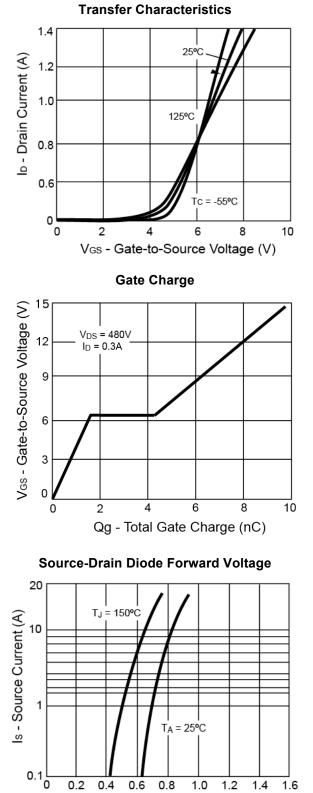
c. Switching time is essentially independent of operating temperature.





Tj - Junction Temperature (°C)

Electrical Characteristics Curve (Ta = 25°C, unless otherwise noted)



0.8

Vsp - Source-to-Drain Voltage (V)

1.0

1.2

1.4

0.6

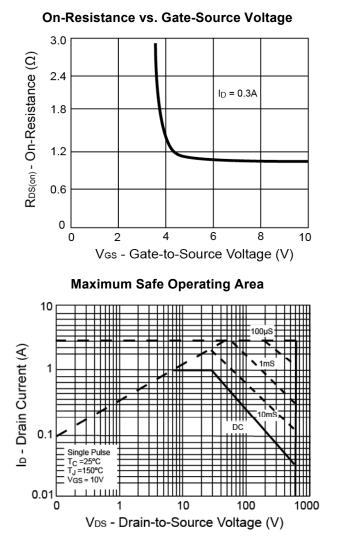
0.2

0.4

1.6

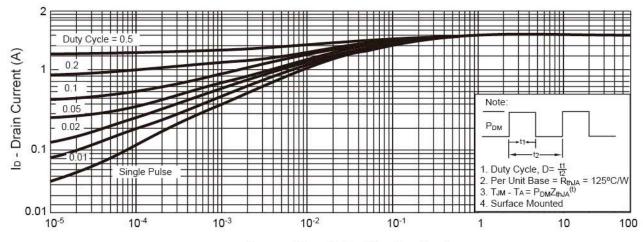


Electrical Characteristics Curve (Ta = 25°C, unless otherwise noted)



Threshold Voltage 1.3 V_{GS(th)} - Gate Threshold Voltage (Normalized) 1.2 1.1 ID = 250µA 1.0 0.9 0.8 0.7 0.6 0.5 0.4 -50 -25 0 25 50 75 100 125 150 Tj - Junction Temperature (°C)

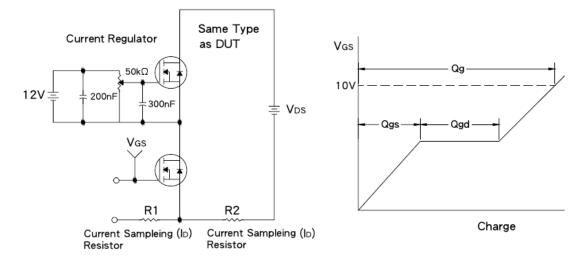
Normalized Thermal Transient Impedance, Junction-to-Ambient



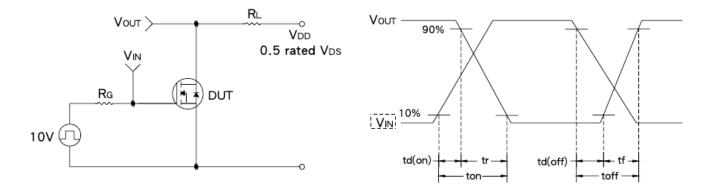
Square Wave Pulse Duration (sec)



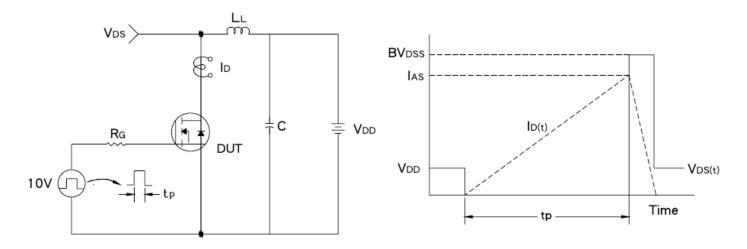
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform

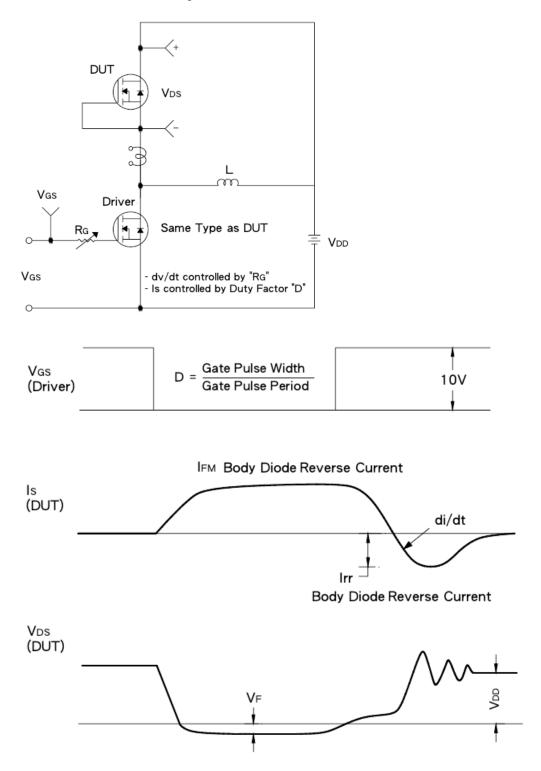


EAS Test Circuit & Waveform



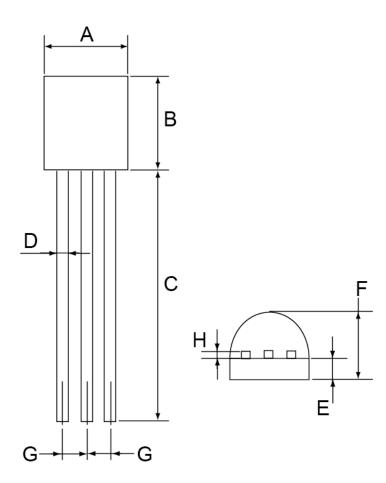


Diode Reverse Recovery Time Test Circuit & Waveform



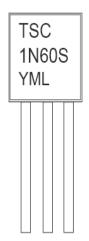


TO-92 Mechanical Drawing



TO-92 DIMENSION					
DIM	MILLIMETERS		INCHES		
וויוט	MIN	MAX	MIN	MAX	
А	4.30	4.70	0.169	0.185	
В	4.30	4.70	0.169	0.185	
С	13.53 (typ)		0.532 (typ)		
D	0.39	0.49	0.015	0.019	
ш	1.18	1.28	0.046	0.050	
F	3.30	3.70	0.130	0.146	
G	1.27	1.31	0.050	0.051	
Н	0.33	0.43	0.013	0.017	

Marking Diagram



- **Y** = Year Code
- M = Month Code

(A=Jan, B=Feb, C=Mar, D=Apl, E=May, F=Jun, G=Jul, H=Aug, I=Sep, J=Oct, K=Nov, L=Dec)

L = Lot Code



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